Search Notes		

Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/057,928	SEGEV, DAVID	
Examiner	Art Unit	_
Jezia Riley	1637	

SEARCHED			
Class	Subclass	Date	Examiner
536	23.1 24.3, 25.3, 25.32		
514	1, 44	5/26/2005	JR
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INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
			,

SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR
Searches from STIC and STN enclosed	5/26/2005	JR